Fifteen Years of the Advanced CCD Imaging Spectrometer

Catherine Grant, Mark Bautz, Peter Ford (MIT Kavli Institute) and Paul Plucinsky (SAO)

5.9 keV FI CCD Measured CTI

2010

T < -118.7 C

-118.7 C < T < -116.7 C

116.7 C < T < -114.7 C

2005

Time (years)

T > -114.7 C

105

2000

Summary

As the Advanced CCD Imaging Spectrometer (ACIS) on the Chandra X-ray Observatory enters its fifteenth year of operation on orbit, it continues to perform well and produce spectacular scientific results. The response of ACIS has evolved over the lifetime of the observatory due to radiation damage, molecular contamination and aging of the spacecraft in general. Here we present highlights from the instrument team's monitoring program and our expectations for the future of ACIS. The ACIS calibration source produces multiple line energies and fully illuminates the entire focal plane which has greatly facilitated the measurement of charge transfer inefficiency and absorption from contamination. While the radioactive decay of the source has decreased its utility, it continues to provide valuable data on the health of the instrument. Performance changes on ACIS continue to be manageable, and do not indicate any limitations on ACIS lifetime.

Instrument and Data

- Advanced CCD Imaging Spectrometer (ACIS)
 - 10 CCDs; 8 front-illuminated (FI), 2 back-illuminated (BI)
 - Simultaneous high-resolution imaging and moderate-resolution spectroscopy
 - Highly-elliptical 64-hour orbit transits radiation belts at perigee
 - Operating temperature -120° C
- ACIS External Calibration Source (ECS)
 - Radioactive Fe-55 with Al and Ti fluorescence targets
 - Strongest line is Mn-Kα (5.9 keV)
 - Observed twice each orbit; before and after radiation belt passages

T < -118.7 C

118.7 C < T < -116.7 C

2005

-116.7 C < T < -114.7 CT > -114.7 C

5.9 keV BI CCD Measured CTI

2010

Time (years)

2015

- Illuminates entire focal plane
- Fe-55 half-life ~ 2.74 years



Charge Transfer Inefficiency

- CTI: Charge transfer inefficiency
 - Caused by manufacturing defects and radiation damage
 - Degrades spectral resolution and detection efficiency
 - Sensitive to temperature and sacrificial charge from the particle background
 - FI and BI CCDs behave differently
 - BI CCDs CTI is much less sensitive to temperature and sacrificial charge
- Parallel transfer CTI:
 - Pre-launch: CTI (FI CCDs) $< 10^{-6}$, CTI (BI CCDs) $\sim 10^{-5}$
 - After initial radiation belt passages (Aug-Sep 1999): CTI (FI) $\sim 10^{-4}$, CTI (BI) $\sim 10^{-5}$
 - After correcting for variations in sacrificial charge and temperature:
 - dCTI/dt (FI) ~ 2×10^{-6} / yr
 - dCTI/dt (BI) ~ 1 × 10⁻⁶ / yr



Particle background at the ACIS detector. Correlated with cosmicray protons (E > 10 MeV); anticorrelated with the solar cycle. Many of the structures are also seen in reverse in the measured CTI.



2015

2000

Evolution of measured CTI for the FI and BI CCDs. The colors indicate times of warmer focal plane temperature which increases CTI. The remaining structure is a combination of real radiation damage and changing particle background.

2005

2000

Evolution of CTI for the FI and BI CCDs after removing variations due to temperature and sacrificial charge from the particle background. Scatter increases toward the end due to reduced count rate from the decaying radioactive source.

Radiation Monitoring

- Effectiveness of on-board particle detector (EPHIN) reduced due to elevated spacecraft temperatures
- ACIS can act as its own radiation monitor which provides some protection against solar storms
- ACIS team has developed a flight software patch; examines ACIS data in real-time and sends alert to Chandra On-Board Computer when it detects high radiation levels
- ACIS flight software patch installed Nov 2011; OBC patched to respond to ACIS on May 2012
 - Operating as expected, no anomalies
 - No impact on science data
 - No false triggers from bright X-ray sources
 - Two real triggers from high radiation environment; prompted Chandra radiation shutdowns
- Patch parameters adjustable to better match changing quiescent particle background
- Grant+ 2012, Proc. SPIE 8443; Ford+ 2012, Proc. SPIE 8443



ACIS threshold crossing rate as a function of time over the entire history of Chandra. The data from each type of CCD have been averaged and put into three minute time bins. This threshold crossing rate includes contributions both from X-ray sources in the field and from the particle background. Vertical enhancements are due to radiation events.

Molecular Contamination

- Hydrocarbon contaminant is accumulating on the ACIS filter
- Strong absorption at low energies, not important above 2 keV
- Thicker near the edges of the focal plane than in the middle
- Deposition rate increasing, related to increasing spacecraft temperatures?
- Marshall+ 2004, Proc. SPIE 5165; O'Dell+ 2013, Proc. SPIE 8859



Drop in low-energy detection efficiency due to accumulating contamination on the optical blocking filter measured at 700 eV and 1.5 keV averaged over the entire ACIS-S3 CCD

Future Prospects

- Chandra lifetime not limited by consumables or orbit; no known limitations to a mission of 25 years or longer (Tenenbourg 2014, DDD, 77 r. (002)
- Performance changes continue to be manageable, do not limit ACIS lifetime
 - CTI increase is relatively small, requires periodic calibration

mission of 25 years or longer (Tananbaum+ 2014, RPPh 77, p. 6902)

- Thermal control becoming more difficult, reducing flexibility in operations & mission planning; not a hazard to continued operation
 - Software tools have been developed which follow small temperature variations, adjust calibration products accordingly
- Instrument anomalies have been infrequent with limited impact on science
- Loss of low-energy efficiency due to contamination, potentially more significant
- Reduced thermal control may require raising nominal focal plane temperature
 - Requires substantial recalibration effort
 - Spectral resolution is decreased at higher temperatures
- We look forward to at least another fifteen years of spectacular ACIS science!